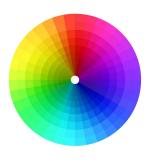


Order Selection



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2019-09-23

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Summary from last lecture

- ▶ Alternatives to NLS, based on ARMA and covariance model
- ► HOYW, MUSIC, Min-Norm, ESPRIT
- Subspace methods using EVD/SVD
- Complicated derivation but easy to use (and implement)
- ▶ Need to select user parameters and model order



Today

- ▶ How to choose the model order for parametric methods?
- ► Heuristic approaches
- ► Information criteria
- ► Intuitive ARMA order selection



Parametric signal models

$$y(t) = \sum_{k=1}^{n} \alpha_k e^{i(\omega_k t + \varphi_k)} + e(t)$$

$$A(z)y(t) = B(z)e(t)$$

$$A(z) = 1 + a_1 z^{-1} + \dots + a_n z^{-n}$$

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Remaining problem

What is n and $m \in \mathbb{N}$?

How to estimate the **discrete** parameters?



Definitions

Refer to n as the model order, or rather, the number of parameters, and N as the number of *real-valued* samples

$$\theta \in \mathbb{R}^n, \quad y \in \mathbb{R}^N$$



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For $\{y(t)\}_{t=1}^{N_s}$ complex-valued samples from the line spectra model

$$y(t) = \sum_{k=1}^{n_c} \alpha_k e^{i(\omega_k t + \varphi_k)} + e(t)$$

we have

$$N = 2N_s$$
$$n = 3n_c + 1$$

that is, both real and imaginary part of the data, and three parameters per component plus the noise variance are unknown



Rule of thumb

General

It is always possible to get a better model fit if we increase the model order ("increase flexibility").

- Infinite order is not better (or even possible)!
- Does not explain the underlying structure
- Fits to the random noise, giving random estimates (overfitting)



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Heuristic approach (Occam's razor)

We need to choose n high enough that the model gives a sufficient description of the data, while still keeping n << N to get reliable (low variance) estimates.

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In practice

Principle of parsimony idea

Increase the order as long as the error reduces significantly

- Subjective but reasonable
- An even lower model order might still be enough for your purpose
- ▶ What is significant?

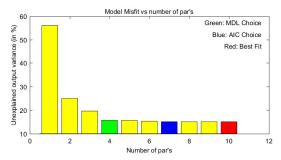


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- ► Many application specific methods (of limited applicability)
- ► **Here:** General rules associated with the Maximum Likelihood Method (MLM)



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Maximum likelihood

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$$\hat{\theta} = \underset{\theta}{\operatorname{argmax}} \ p(y|\theta) = \underset{\theta}{\operatorname{argmin}} \ - \ln \left(p(y|\theta) \right)$$



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- Reduces to NLS for Gaussian data



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► Minimizer:

$$\hat{\gamma} = \underset{\gamma}{\operatorname{argmin}} \ \|y - f(\gamma)\|^2 \quad \text{and} \quad \hat{\sigma}^2 = \frac{1}{N} \|y - f(\hat{\gamma})\|^2$$



Maximum a posteriori (MAP)

Hypothesis: H_n denotes that the model order is n

Bayes rule:

$$p(H_n|y) = \frac{p(y|H_n)p(H_n)}{p(y)}$$

where $p(H_n)$ is the a priori probability of H_n



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MAP

Find the most probable order, given the data, through

$$\max_{n\in[1,\ \bar{n}]} p(y|H_n)p(H_n)$$

p(y) is just a normalization factor independent of n



A few different rules

Derived from statistical reasoning and information theory (Maximum a posteriori or Kullback-Leibler information)

Four methods we will look at (listed by increasing "performance")

- Akaike information criterion (AIC)
- Corrected Akaike information criterion (AIC_c)
- Generalized information criterion (GIC)
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See the book for derivations (beyond our scope).



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Several other criteria available too:

- ► Minimum description length (MDL)
- ▶ etc...



Statistical approach

Reasonable idea: Add a term to the fitting problem that depends on n, penalizing high order.

Family of selection rules

minimize
$$-2\ln(p_n(y|\theta_n)) + \eta(n,N)n$$

where θ_n is used as a reminder that θ is of length n

The penalty coefficients $\eta(n, N)$ are given by

$$\begin{aligned} &\mathsf{AIC}: \eta(n,N) = 2\\ &\mathsf{AIC_c}: \eta(n,N) = 2\frac{N}{N-n-1}\\ &\mathsf{GIC}: \eta(n,N) = \nu \in [2,\ 6]\\ &\mathsf{BIC}: \eta(n,N) = \ln N \end{aligned}$$



Penalty comparison

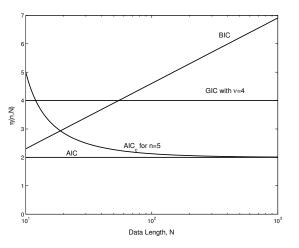


Figure C.1. Penalty coefficients of AIC, GIC with $\nu = 4$ ($\rho = 3$), AIC_c (for n=5), and BIC, as functions of data length N.



Practical considerations

► Hard to solve

$$\min_{\theta_n,n} -2\ln(p_n(y|\theta_n)) + \eta(n,N)n$$

lacktriangle Assuming Gaussian noise, inserting the solution for fixed n

$$-2\ln(p_n(y|\hat{\theta}_n)) = N\ln(2\pi) + N + N\ln(\hat{\sigma}_n^2),$$

where
$$\hat{\sigma}_n^2 = \frac{1}{N} ||y - f(\hat{\gamma_n})||^2$$
.

Solution: Compute $\hat{\sigma}_n^2$ for many n, and choose the solution that minimize

$$N\ln(\hat{\sigma}_n^2) + \eta(n,N)n.$$



Example: Line spectra

For some fixed order n_c of the complex-valued signal model, and the estimated parameters for that order, we have

$$\hat{\sigma}_{n_c}^2 = \frac{1}{N_s} \sum_{t=1}^{N_s} \left| y(t) - \sum_{k=1}^{n_c} \hat{\alpha}_k e^{i(\hat{\omega}_k + \hat{\varphi}_k)} \right|$$

which can be computed for every order n_c



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which can be computed for every order n_c

We can then compute, e.g. the AIC, as

$$AIC(n_c) = 2N_s \ln(\hat{\sigma}_{n_c}^2) + 2(3n_c + 1)$$

and choose the order that minimizes the AIC

- ▶ We need to compute the error (MSE) for many model orders
- ▶ Then we can choose based on some information criteria



Considerations

- Automatic order selection is possible
- Now we have several criteria, how do we choose?
 - Pick your favorite
 - Look at all of them to make a final decision
 - Combine the information based approaches
- Computational burden can be a problem
- Methods can "fail"
- An informed guess can still be better
- Non-parametric approaches avoids this problem (almost)

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ARMA order selection

Heuristic for ARMA (or linear systems)

Reduce order if you have pole/zero cancellation, i.e., if there are estimated poles and zeros that overlap (more or less) they may not influence the result.

$$y(t) = \frac{B(z)}{A(z)}e(t) = \frac{\tilde{B}(z)(1 - kz^{-1})}{\tilde{A}(z)(1 - kz^{-1})}e(t) = \frac{\tilde{B}(z)}{\tilde{A}(z)}e(t)$$

where \tilde{B} and \tilde{A} have lower order

- Model specific approach (but quite general)
- Easy to use
- Intuitive



Useful functions

Custom functions implemented:

- ▶ armaorder(mvec, sig2, N, nu)
- sinorder(mvec,sig2,N,nu)

Usage:

- mvec: vector of number of sinusoids (or complex exponentials for complex valued data)
- \blacktriangleright sig2: vector mean square errors (that is, estimate of σ^2) for model orders given in mvec
- N: number of real-valued data points
- ▶ nu: GIC parameter (usually $\nu \in [2, 6]$, default=4)
- output: the model orders that minimizes the AIC, AICc, GIC, and BIC criterions



Summary

- Out of a selection of models that are sufficient for the application, choose the simplest one
- ▶ In general: try to choose n << N
- ► Look at the increase in performance (decrease in error) as a function of *n*
- ▶ BIC, GIC, AIC_c, AIC can give automatic guidance
- ► Study your model and simplify (e.g. pole/zero cancellation)



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In the end, try several things to make yourself comfortable with a certain choice of \boldsymbol{n}

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